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(54) **Magnetoelectric device**

(57) A magnetoelectric device responsive to an applied magnetic field, e.g. for use as a reading head for data stored in magnetic storage media, comprises first and second ferromagnetic regions (3, 4) with a channel region (5) between them, the ferromagnetic regions being configured so that charge carriers with a particular spin polarisation which can pass through the first region, pass through the second region as a function of the relative orientations of magnetisation of the ferromagnetic

regions produced by the applied magnetic field such that the device exhibits a conductivity as a function of the strength of the applied field. The channel region (5) includes a nanotube (6) which may be formed of carbon, configured to provide a quasi-one-dimensional channel to cause charge carriers which pass through the first ferromagnetic region to maintain their spin polarisation as they pass towards the second ferromagnetic region. In an alternative embodiment a deposited carbon layer (14) is used in the channel region.

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Description

[0001] This invention relates to a magnetoelectric device responsive to an applied magnetic field, which has particular but not exclusive application to a magnetic reading head for reading data from magnetic storage media.

[0002] Large magnetoresistance can be observed in certain structures that include regions of ferromagnetic material which are separated by regions of non-magnetic material. In these structures, the resistance drops dramatically as a magnetic field is applied, the change being much greater than for a single ferromagnetic film. The effect is believed to be due to relative alignment of the magnetisation directions of different layers of the structure. For example, considering a structure that comprises first and second ferromagnetic layers, when the magnetisation direction of the two ferromagnetic layers are aligned in anti-parallel, electrons with a particular spin can pass through one of the layers but are blocked by the other layer and cannot pass through it. However, in response to an applied magnetic field, the magnetisation direction of one of the layers can be made to flip into parallel with the other layer. Then, electrons with a spin orientation that can pass through the first ferromagnetic layer, will also freely pass through the second ferromagnetic layer, resulting in a relatively low resistance. The effect can therefore be used to detect the presence of an applied magnetic field.

[0003] A giant magnetic tunnelling effect has been observed in cobalt containing ferromagnetic layers spaced apart by an insulating tunnelling barrier of aluminium oxide, as described by T. Miyazaka and N. Tezuka "Giant Magnetic Tunnelling Effect in Fe/Al₂O₃/Fe junction", J. Magn. Magn. Mater. 139, L231-L234. It has been proposed to use a magnetoelectric device of this general configuration in a magnetic reading head, as described in "TMR as a promising device for third generation hard disk drive heads" Nikkei Electronics 1997, 47 No. 686 pp 125-129. The magnetoelectric device used in the reading head comprises first and second overlying ferromagnetic layers formed of cobalt with a thickness of 3.3nm, sandwiching a tunnelling insulating Al₂O₃ layer of thickness 1.3nm, to act as a thin tunnelling barrier to channel electrons between the ferromagnetic layers. The various layers are deposited sequentially on an insulating substrate. The tunnel barrier of Al₂O₃ is formed by oxidising a thin aluminium layer deposited on one of the cobalt layers. The oxidation process takes 10 hours or longer which slows the manufacturing process. Furthermore, the aluminium oxide film needs to have a high quality and uniformity in order to render the device sensitive to an applied magnetic field. Short circuits due to pin holes through the tunnelling barrier constitute a serious problem. Furthermore, the magnetoelectric device needs to be made sufficiently small to detect individual storage areas on magnetic media with the result that the resistance through the device is relatively high

and sensitive to external noise.

[0004] The present invention seeks to provide an improved device which overcomes these problems.

[0005] According to the invention there is provided a magnetoelectric device responsive to an applied magnetic field, comprising first and second ferromagnetic regions with a channel region between them, the ferromagnetic regions being configured so that charge carriers with a particular spin polarisation which can pass through the first region, pass through the second region as a function of the relative orientations of magnetisation of the ferromagnetic regions produced by the applied magnetic field whereby the device exhibits a conductivity as a function of the strength of the applied field, wherein that the channel region is configured to provide a quasi-one-dimensional channel to cause charge carriers which pass through the first ferromagnetic region to maintain their spin polarisation as they pass towards the second ferromagnetic region.

[0006] The quasi-one-dimensional channel may comprise a nanotube, which may be formed of carbon. The channel region may comprise a bundle of such nanotubes.

[0007] The channel region in another aspect of the invention may comprise a layer of graphite or a diamond layer.

[0008] The invention also includes a magnetoelectric device responsive to an applied magnetic field, comprising first and second ferromagnetic regions with a channel region between them, characterised in that the channel region includes a carbon containing material.

[0009] The invention also includes a magnetoelectric device responsive to an applied magnetic field, comprising first and second ferromagnetic regions with a channel region between them characterised in that the channel region includes a nanotube.

[0010] In order that the invention may be more fully understood an embodiment thereof will now be described by way of example with reference to the accompanying drawings in which:

Figure 1 is a schematic cross sectional view of the first example of magnetoelectric device according to the invention;

Figure 2 is a schematic plan view of the device shown in Figure 1;

Figure 3 is an electron beam micrograph of the channel region of the device shown in Figures 1 and 2;

Figure 4 is a graph of the resistance of the device as a function of applied magnetic field;

Figure 5 is a table illustrating the relationship between resistance, spin orientation and field strength;

Figure 6a-h illustrate process steps of a first fabrication method of making a device according to the invention showing the various steps in plan and sectional view respectively;

Figure 7a-n correspondingly illustrate a second fabrication method for a device according to the invention;

Figure 8 is a schematic plan view of a further embodiment of magnetoelectric device according to the invention in which the carbon nanotube is configured as a bridge;

Figure 9 is a schematic plan view of another device according to the invention in which the carbon nanotube is arranged at side edges of the ferromagnetic regions;

Figure 10 is a schematic plan view of a magnetoelectric device using a plurality of carbon nanotubes; Figure 11 is a schematic view of a device in which the plurality of nanotube are arranged in a bridge configuration;

Figure 12 illustrates in perspective view another device according to the invention using a bundle of nanotubes upstanding from the substrate;

Figure 13 illustrates in plan view another device according to the invention using a bundle of nanotubes disposed transversely on the substrate;

Figure 14 illustrates another device in plan view in which the bundle of nanotubes is arranged as a bridge between the ferromagnetic regions;

Figure 15 is a schematic plan view of a device using a carbon graphite or diamond tunnelling region;

Figure 16 corresponds to Figure 15 in which the carbon region is arranged as a bridge between the ferromagnetic regions;

Figure 17 is another example of a device according to the invention using a carbon graphite film on the substrate;

Figure 18 illustrates a device with a doped substrate to receive a gate voltage;

Figure 19 is a plan view of a device according to the invention with a side gate;

Figures 20a-h illustrate process steps for making another example of spin device according to the invention;

Figure 21 illustrates a first example of a magnetic reading head incorporating a magnetoelectric device according to the invention; and

Figure 22 illustrates another example of magnetic reading head incorporating the inventive magnetoelectric device.

[0011] A first embodiment of a magnetoelectric device according to the invention is shown in Figures 1 to 3. Referring to the sectional view of Figure 1, the device comprises generally planar support 1 which may comprise a semiconductor wafer or could comprise a metal plate. An insulating substrate 2 is formed on the wafer 1 e.g. of SiO₂ or SiN. First and second ferromagnetic regions 3, 4 are formed on the substrate 2, with a channel region 5 between them. In this embodiment, the channel region 5 has a width L_{gap} between the first and second ferromagnetic regions 3, 4 which may be of the

order of 250nm. The ferromagnetic regions 3,4 may be made of cobalt deposited to a thickness of 50-100 nm. Typical dimensions for the region 3 are 2 by 2 microns although the invention is not restricted to these dimensions. As will be explained in more detail later, the regions 3,4 have slightly different surface areas to give them asymmetrical magnetisation characteristics.

[0012] In this example of the invention, a carbon nanotube 6 extends through the channel region 5 between the ferromagnetic regions 3, 4 in order to channel electrons between them. The direction of current flow is shown by arrows 7 in Figure 2. As known in the art, carbon nanotubes comprise hollow, generally cylindrical members with a diameter typically in the range of 1.4 - 20nm and a length of the order of 65 micrometers. Either single or multi-walled nanotubes can be used. Carbon nanotubes are commercially available from Shinku Yakin K.K. of Japan. Nanotubes are described in more detail in "Physical Properties of Carbon Nanotubes," R. Saito, G. Dresselhaus and M.S. Dresselhaus, Imperial College Press, London, 1998.

[0013] Figure 4 illustrates the resistive characteristics of the device in the presence of a magnetic field. When a relatively high magnetic field is applied to the magnetoelectric device (region A) the high field causes the magnetisation directions for the ferromagnetic regions 3, 4 to become aligned with the field. A characteristic of ferromagnetic material is that the majority of the conduction electrons have a spin-orientation corresponding to the magnetisation direction of the ferromagnetic material. For instance, in the high positive field condition A, the majority of electrons in layer 4 will have a spin orientation corresponding to the upright arrow shown in Figure 5 (row 1). The electrons pass from the layer 4 through the carbon nanotube 6 to the ferromagnetic layer 3 with little spin scattering, due to carbon nanotube having a large spin-scattering length. The high field, as previously explained, aligns the magnetisation directions for the layers 3 and 4 in parallel. Since the majority spin states are also aligned, the device exhibits a relatively low resistance.

[0014] When the field is reduced to a low value (region B of Figure 4) one of the layers 3, 4 flips its magnetisation direction into an anti-parallel configuration as shown in row 2 of Figure 5. In this situation, the majority spin states are out of alignment. As a result, the device exhibits high resistance.

[0015] The flipping of one of the layers into the antiparallel magnetisation configuration in the low strength field, results from the layers 3, 4 exhibiting slightly different bulk coersivities due to their different surface areas, so that one of the layers flips its orientation direction before the other in response to the decreasing field.

[0016] If the field direction is reversed and a high negative field is applied, the magnetisation of the second layer eventually also flips in the direction of the applied field. In this situation, the majority spin states of both layers are once again aligned, so the device exhibits a

[0022] Additional metallic contact layers of Au (not shown) are provided on the ferromagnetic regions 3, 4 to allow an external voltage source to be connected so that the resistance of the device can be measured to

[0027] Various other modifications and variations fall within the scope of the invention. For example, referring to Figure 8, the fabrication process can be modified to deposit the first and second ferromagnetic regions 3, 4 firstly and thereafter to position the carbon nanotube

overlying the ferromagnetic regions as a bridge. The nanotube 6 may be positioned using an atomic force microscope or by modifying the surface of the oxide layer 2 chemically, either to attract or repel nanotubes. Also, as shown in Figure 9, the nanotube 6 may be positioned in contact with side edges of the regions 3, 4 rather than bridging them as shown in Figure 8.

[0028] Furthermore, in order to reduce the electrical resistance, a plurality of nanotubes 6 may be used as shown in Figure 10 and 11. In Figure 10, the nanotubes 6 are arranged in contact with ferromagnetic regions 3, 4 formed by either of the processes previously described with reference to Figures 6 and 7. Alternatively, the nanotubes may bridge the ferromagnetic regions 3, 4 as shown in Figure 11. In another modification shown in Figure 12, the nanotubes 6 are arranged upstanding from the substrate 2 with the ferromagnetic regions 3, 4 above and below their ends.

[0029] As known in the art, carbon nanotubes can aggregate to form a bundle and this can be utilised in devices according to the invention to reduce the electrical resistance. For example, as shown in Figure 13, a bundle of nanotubes 6' is used instead of a single tube on the substrate 2. Also, as shown in Figure 14, the nanotube bundle 6' can bridge the contacts 3, 4 rather than being configured beneath them as shown in Figure 13. A typical nanotube bundle 6' contains between two and several hundred nanotubes although the invention is not restricted to this range.

[0030] Those skilled in the art will appreciate that nanotubes can be made from other materials such as silicon or boron nitride, which may be used as alternatives to the carbon tube 6, 6'.

[0031] Further examples of the invention will now be described that use a channel region with a carbon containing material which, instead of being configured as a nanotube is arranged in a carbon layer. Referring to Figure 15, a region 14 comprising carbon graphite is formed on the substrate 2 by chemical vapour deposition (CVD) to a thickness of 100 nm and is patterned to dimensions of 100 by 100 microns using a photolithographic or e-beam lithographic technique when the substrate is initially prepared, instead of using the nanotube 6. The ferromagnetic regions 3, 4 are then applied as previously described with reference to either Figure 6 or 7. In a modification, the graphite region 14 may be replaced by diamond.

[0032] In an alternative shown in Figure 16, the region 14 is arranged as a bridge between the ferromagnetic regions 3, 4 using conventional lithographic techniques and thermal evaporation.

[0033] In an alternative shown in Figure 17, a region of the substrate 2 that is larger than the ferromagnetic regions 3, 4 is initially deposited with the graphite or diamond layer and the ferromagnetic regions 3, 4 are formed thereon. An example of the dimensions for the region 14 is 100 by 100 microns and for the regions 3, 4 is 2 by 2 microns. The resulting magnetoelectric de-

vice that uses the carbon graphite/diamond layer exhibits an improved resistance characteristic as compared with the Al_2O_3 insulating layers used in the prior art.

[0034] The magnetoelectric device according to the invention may be provided with a gate to control its conduction characteristics. As shown in Figure 18, an example of the device using a carbon nanotube 6 is provided with a doped region 15 in the substrate 1 to allow a gate voltage V_{gate} to be applied to influence charge tunnelling through the channel region 5. In an alternative shown in Figure 19, a side gate 15 is provided on the surface of the substrate, by conventional photolithographic techniques, to apply a field to control conduction through the tunnel channel region 5, along the nanotube 6.

[0035] Another fabrication process for a device according to the invention will now be described with reference to Figure 20. A silicon substrate 1 is prepared with an overlying 200nm SiO_2 layer, with a nanotube 6 thereon, as previously described with reference to Figure 1. This is shown in Figure 20a.

[0036] Then, as shown in Figure 20b, a series of resist layers 16, 17, 18 are spun successively onto the substrate. The lowermost layer 16 comprises MMA or MAA and is deposited to a thickness of 300 nm. The layer 16 is overlaid by the first PMMA layer 17 of a material with a higher molecular weight than the layer 16, to a thickness of 50 nm. This is overlaid by a second layer of PMMA resist 18 of a higher molecular weight than the layer 17, to a thickness of 50 nm.

[0037] The resist layers are then exposed to an electron beam 19 which exposes regions corresponding to the eventual first and second ferromagnetic regions 3, 4, in a manner known *per se*.

[0038] The resist layers are then developed as shown in Figure 20c using a conventional developer such as IPA or MIBK, so as to open windows 20, 20' in the resist layers corresponding to the eventual ferromagnetic regions 3, 4, at opposite ends of the nanotube 6. The rate of dissolution of layer 16 is greater than that of layer 17, which in turn is greater than layer 18 as a result of their relative molecular weights. This gives rise to the stepped configuration of the layers 16, 17, 18 as shown in Figure 20c.

[0039] Then, the ferromagnetic materials are deposited by evaporation into the windows 20, 20'. Referring to Figure 20d, the substrate 1 is mounted in an evacuation chamber on a pivotally mounted holder so that it can be turned at different angles relative to an induction boat (not shown) which produces a stream of evaporated material, directed towards the substrate.

[0040] Referring to Figure 20d, the substrate 1 is pivoted so that the evaporated material is directed at an acute angle shown by arrows 21, 21' into the windows 20, 20'. As a result, a first ferromagnetic material, which may be Fe, Co or Ni, is deposited on the left hand side of each window 20, 20' as layers 22, 22', in electrical contact with opposite ends of the nanotube 6. The evap-

oration process is carried out at room temperature and at a pressure of 4×10^{-7} torr. The layer 22, 22' is deposited to a thickness of 30 nm.

[0041] Then, as shown in Figure 20d, the substrate 1 is pivoted in its holder relative to the induction boat so that a second evaporation can take place at an obtuse angle relative to the boat, so as to deposit material at the right hand side of each window 20, 20' as illustrated by arrows 23, 23'. A further ferromagnetic material is thereby deposited as layer regions 24, 24' at the right hand side of each window 20, 20'. The second ferromagnetic material 24, 24' may be of the same or different composition as compared with the material of layer 22, 22'. It will be seen that the layer 24 contacts the nanotube for the most part in the window 20, whereas the layer 24' contacts the nanotube for the most part in the opposite window 20'. Thus, ferromagnetic materials with different coersivity characteristics can be provided in the windows 20, 20' individually.

[0042] The deposition conditions for layer 23 are substantially the same as those previously described for layer 22, which is deposited to a thickness of 30 nm.

[0043] Then, as shown in Figure 20f, the substrate is pivoted to a central position directly below the induction boat so that a further evaporation process can be carried out in the direction of arrows 25, 25'. In this way, an overlying contact layer 26, 26' is deposited in the windows 20, 20' typically to a thickness of 60 nm. This capping layer, which may be formed of Au, protects the surface of the ferromagnetic material.

[0044] Then, as shown in Figure 20g, the remaining resist layers are lifted off using acetone developer as previously described with reference to Figures 6 and 7, so as to leave the deposited layers 22, 24 and 26 at opposite ends of the nanotube 6, thereby to provide the first and second ferromagnetic regions 3, 4 with the gap 5 between them.

[0045] Figure 21 illustrates schematically an example of a magnetic reading head for use with magnetic storage medium such as a Winchester disc, incorporating a magnetoelectric device according to the invention. A substrate 21 incorporating the magnetoelectric device made according to any of the preceding examples is mounted between two current supply electrodes 27, 28 that are connected to the first and second ferromagnetic regions 3, 4, with channel tunnelling region 5 between them. The head is located over a magnetic storage medium such as the surface of a Winchester disc which contains tracks of magnetically recorded binary 1's and 0's. Three recorded bits b1, b2, b3, are shown schematically recorded in a track T1 in the magnetic recording medium. The bits may be recorded using a conventional induction coil (not shown) and a writing head 29 shown schematically. Magnetic shielding layers 30, 31 are provided on opposite sides of the head.

[0046] As the head is swept along the track, the applied field produced by the recorded bits changes between relatively high and low values depending on

whether the underlying bit is 1 or 0. The changes in magnetic field produce corresponding changes in the current flowing between electrodes 27, 28, which can be detected by external circuitry (not shown) to detect the recorded information from the track T1.

[0047] A similar head is shown in Figure 22 and like parts are marked with the same reference numbers. In this example, the substrate 21 is disposed parallel with the surface of the track T1 and the electrodes 27, 28 extend orthogonally from it in contact with the ferromagnetic regions 3, 4.

[0048] The described examples of the invention have the advantage that the resistance of the reading head is reduced significantly as compared with conventional devices using an Al_2O_3 insulating film between the ferromagnetic layers. As a result, the device is less susceptible to external noise and provides an improved signal to noise ratio in its output.

Claims

1. A magnetoelectric device responsive to an applied magnetic field, comprising first and second ferromagnetic regions with a channel region between them, the ferromagnetic regions being configured so that charge carriers with a particular spin polarisation which can pass through the first region, pass through the second region as a function of the relative orientations of magnetisation of the ferromagnetic regions produced by the applied magnetic field whereby the device exhibits a conductivity as a function of the strength of the applied field, **characterised in that** the channel region is configured to provide a quasi-one-dimensional channel to cause charge carriers which pass through the first ferromagnetic region to maintain their spin polarisation as they pass towards the second ferromagnetic region.
2. A magnetoelectric device according to claim 1 wherein the channel region includes a nanotube.
3. A magnetoelectric device according to claim 2 wherein the channel region comprises a bundle of nanotubes.
4. A magnetoelectric device according to claim 2 or 3 wherein the or each nanotube is made of carbon.
5. A magnetoelectric device according to claim 1 wherein the channel region includes a layer of carbon containing material.
6. A magnetoelectric device according to claim 3 wherein the channel region comprises a layer of graphite.

7. A magnetoelectric device according to claim 3 wherein the channel region comprises a diamond layer.
8. A magnetoelectric device responsive to an applied magnetic field, comprising first and second ferromagnetic regions with a channel region between them, **characterised in that** the channel region includes a carbon containing material.
9. A magnetoelectric device according to claim 8 wherein the channel region includes a carbon nanotube.
10. A magnetoelectric device according to claim 9 wherein the channel region comprises a bundle of nanotubes.
11. A magnetoelectric device according to claim 8 wherein the channel region comprises a layer of graphite.
12. A magnetoelectric device according to claim 8 wherein the channel region comprises a diamond layer.
13. A magnetoelectric device responsive to an applied magnetic field, comprising first and second ferromagnetic regions with a channel region between them **characterised in that** the channel region includes a nanotube.
14. A magnetoelectric device according to claim 13 wherein the channel region comprises a bundle of nanotubes.
15. A magnetoelectric device according to claim 13 wherein the nanotube is made of carbon.
16. A magnetoelectric device according to claim 13 wherein the nanotube is formed of boron nitride.
17. A magnetoelectric device according to claim 13 wherein the nanotube is formed of silicon.
18. A magnetoelectric device according to any preceding claim wherein the first and second ferromagnetic regions comprise layers on a common substrate.
19. A magnetoelectric device according to claim 18 wherein the substrate made of a metal, glass or silicon, and covered with an insulating layer on which the ferromagnetic layers are formed.
20. A magnetoelectric device according to claim 19 wherein the insulating layer comprises silicon oxide or nitride.
21. A magnetoelectric device according to any preceding claim wherein the first and second ferromagnetic regions are made of a cobalt containing material.
22. A magnetoelectric device according to any preceding claim including a gate to apply a field to the channel region.
23. A magnetic reading head for reading data from magnetic storage media, the head including a magnetoelectric device according to any preceding claim.

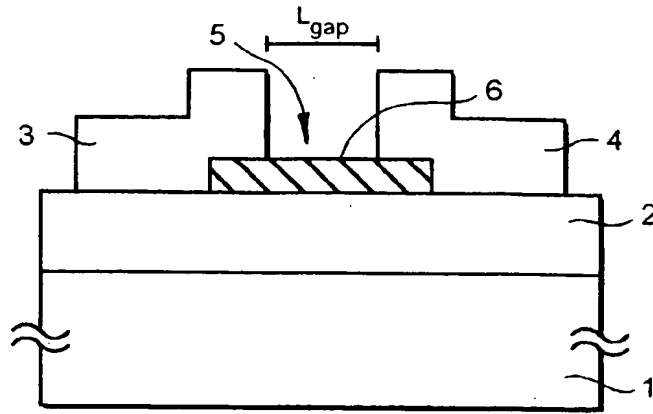


FIG. 1

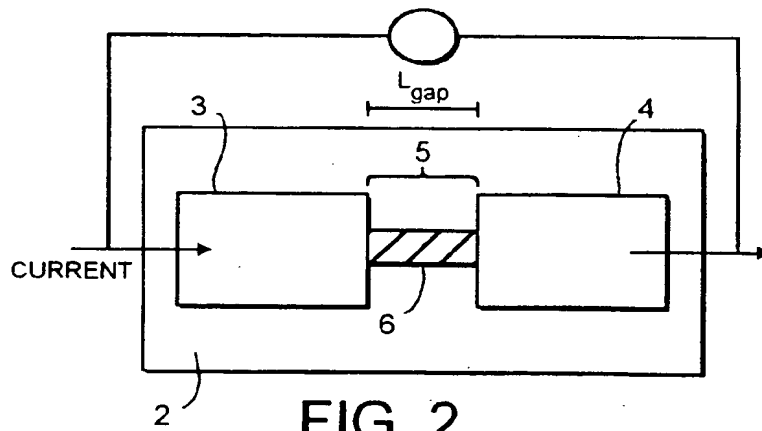


FIG. 2

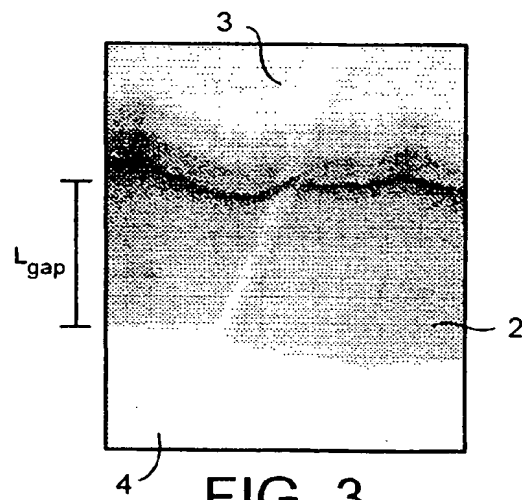


FIG. 3

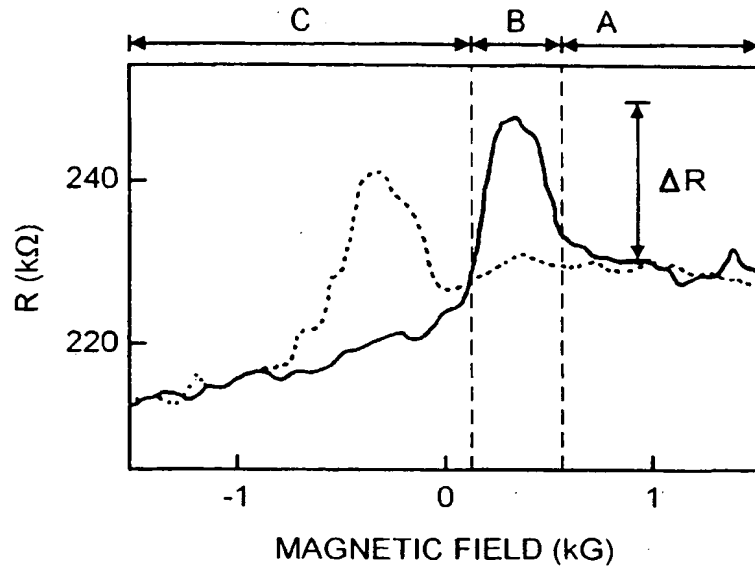


FIG. 4

FIELD STRENGTH		SPIN ORIENTATION		RESISTANCE	ROW
		LAYER 3	LAYER 4		
A	HIGH POSITIVE	↑	↑	LOW	1
B	LOW	↑	↓	HIGH	2
C	HIGH NEGATIVE	↓	↓	LOW	3

FIG. 5

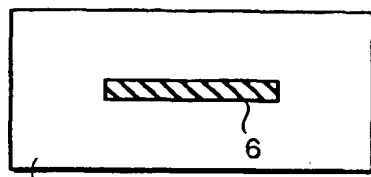


FIG. 6(a)

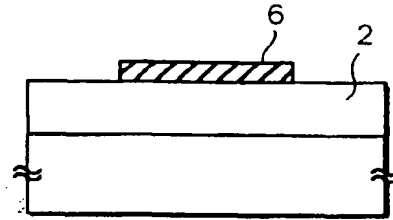


FIG. 6(b)

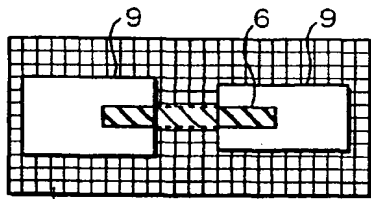


FIG. 6(c)

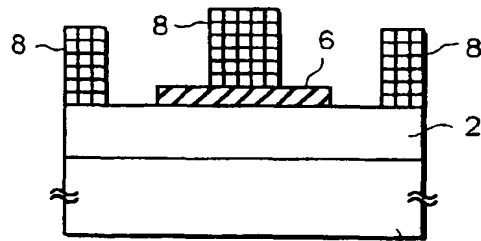


FIG. 6(d)

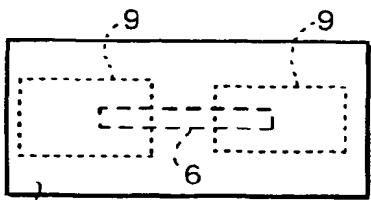


FIG. 6(e)

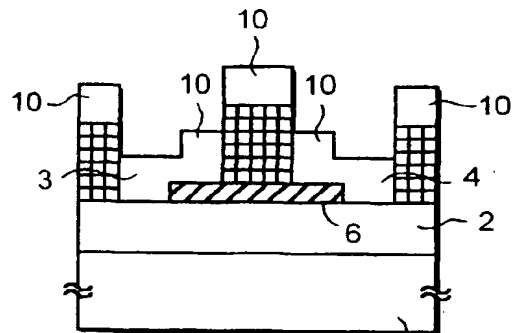


FIG. 6(f)

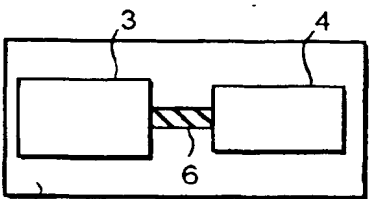


FIG. 6(g)

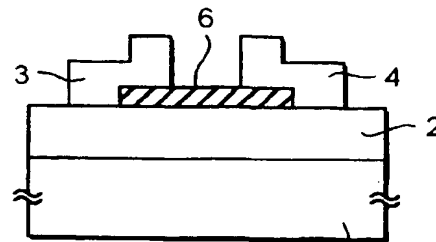


FIG. 6(h)

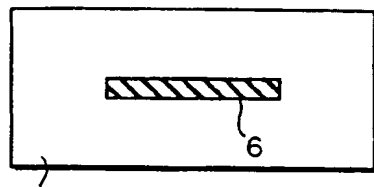


FIG. 7(a)

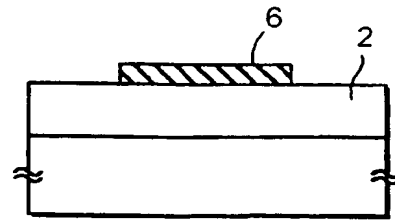


FIG. 7(b)

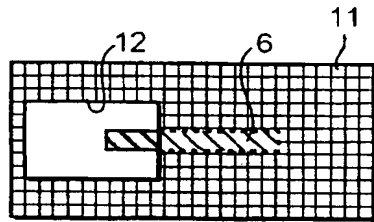


FIG. 7(c)

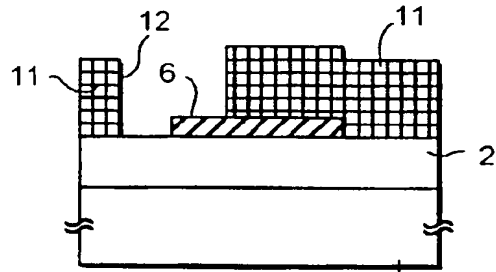


FIG. 7(d)

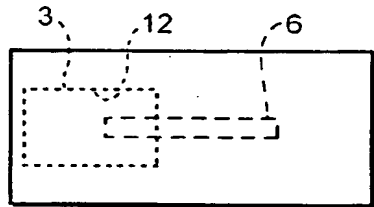


FIG. 7(e)

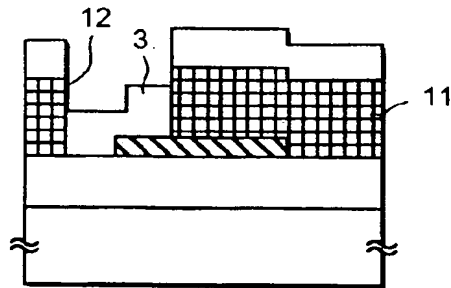


FIG. 7(f)

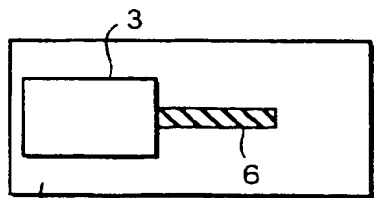


FIG. 7(g)

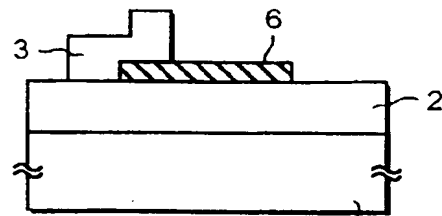


FIG. 7(h)

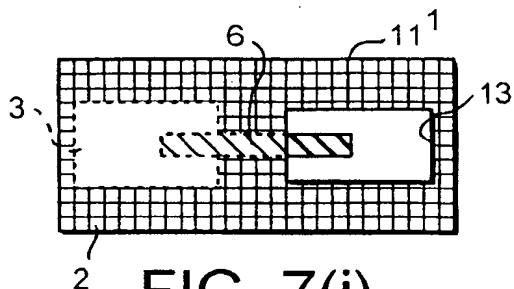


FIG. 7(i)

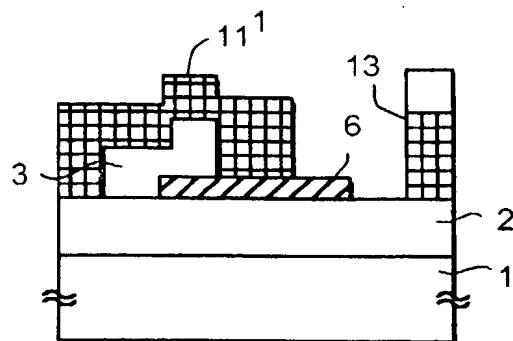


FIG. 7(j)

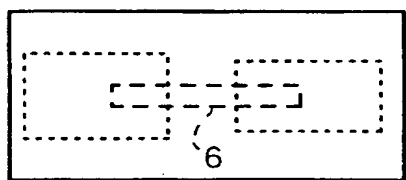


FIG. 7(k)

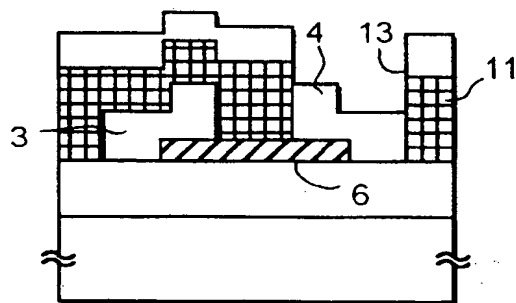


FIG. 7(l)

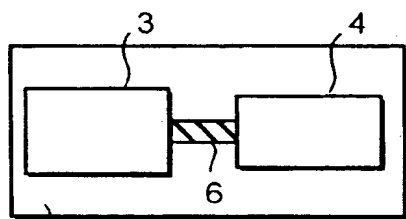


FIG. 7(m)

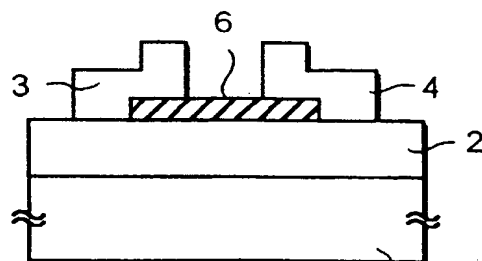


FIG. 7(n)

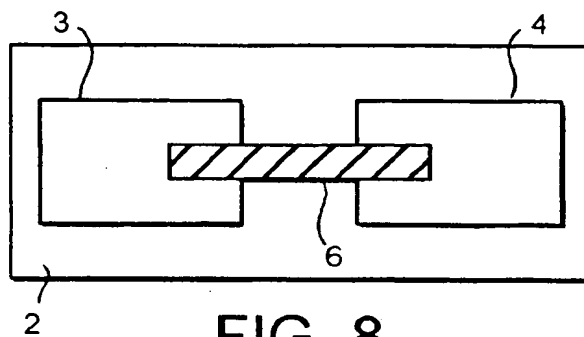


FIG. 8

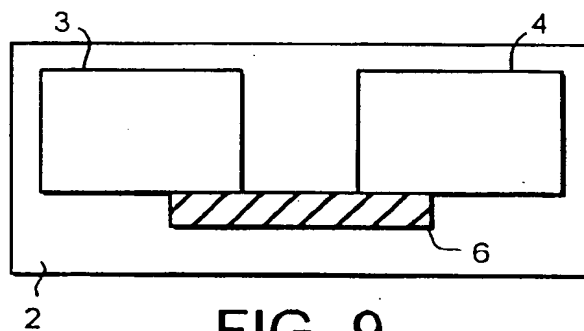


FIG. 9

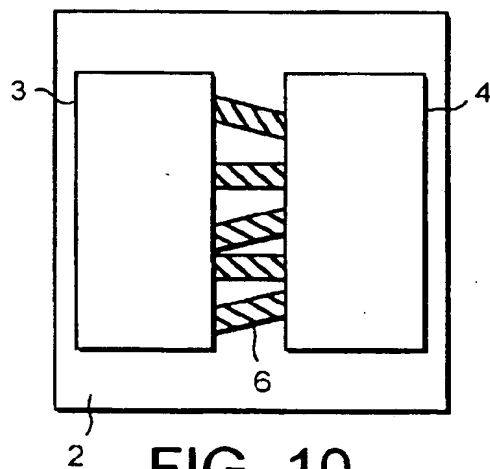
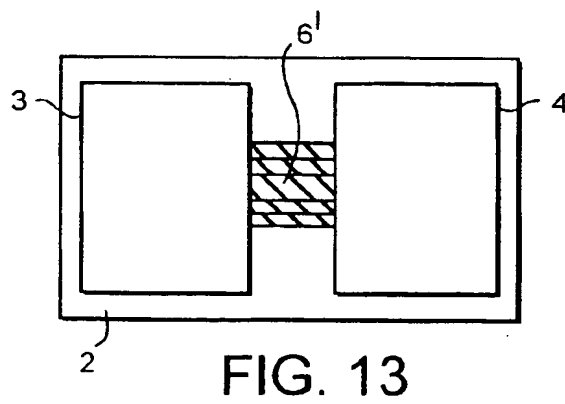
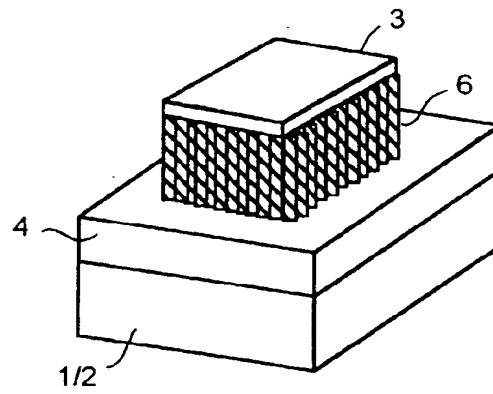
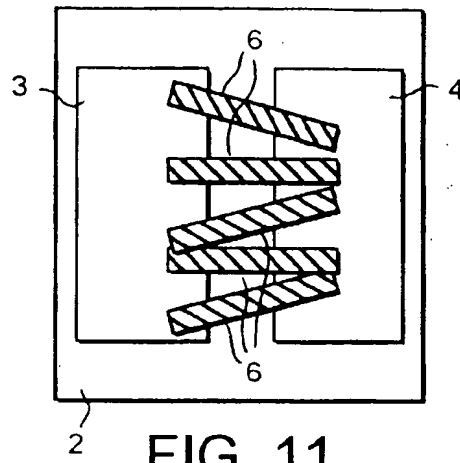
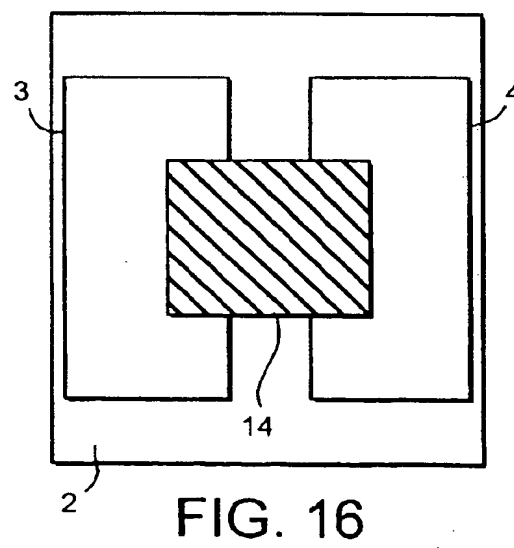
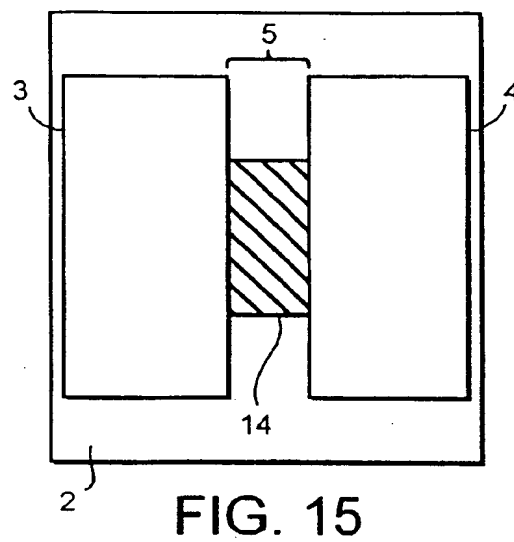
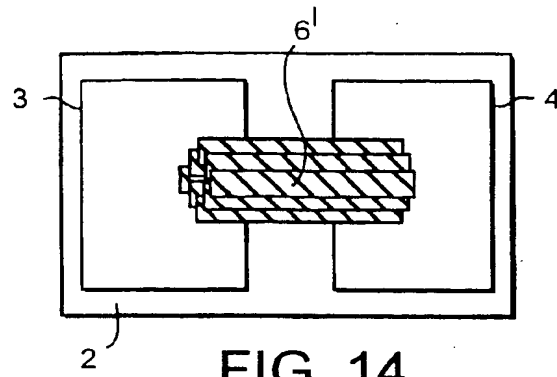


FIG. 10





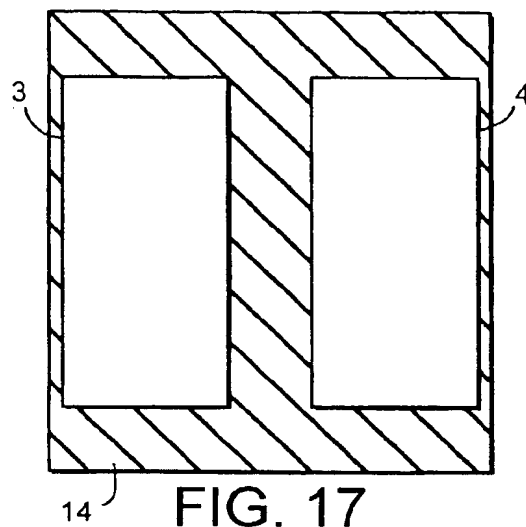


FIG. 17

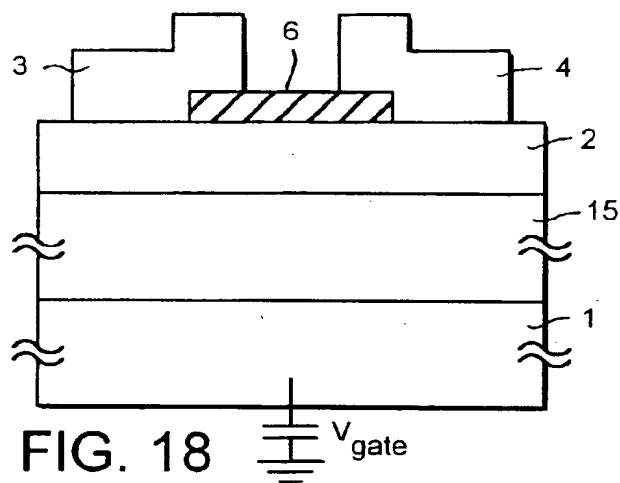


FIG. 18

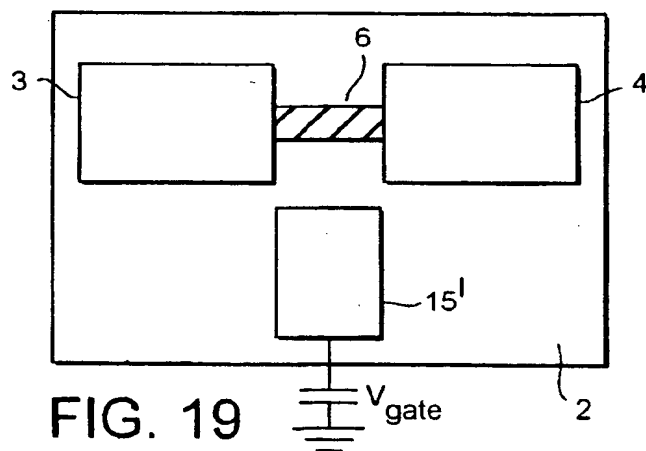


FIG. 19

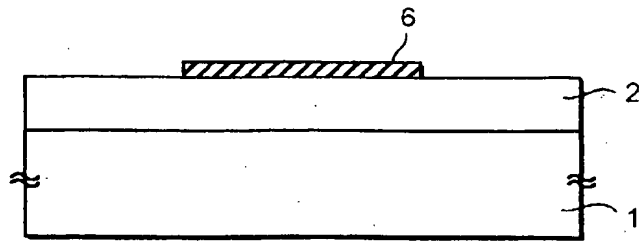


FIG. 20(a)

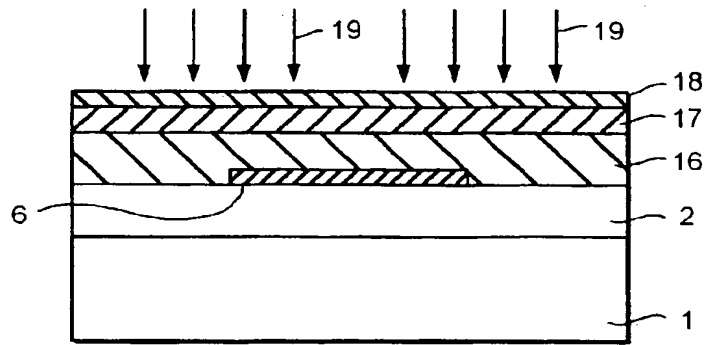


FIG. 20(b)

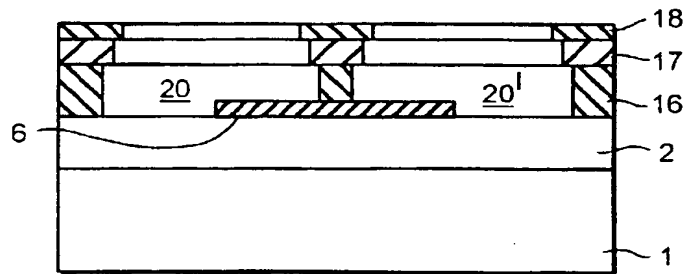


FIG. 20(c)

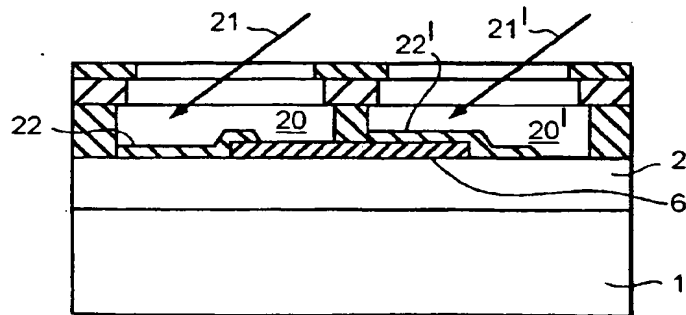


FIG. 20(d)

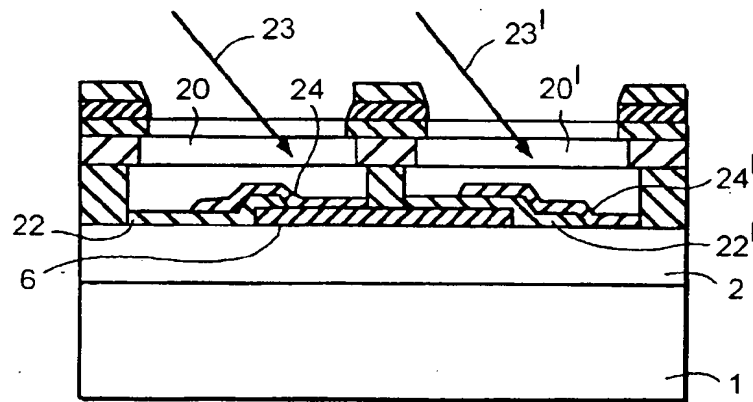


FIG. 20(e)

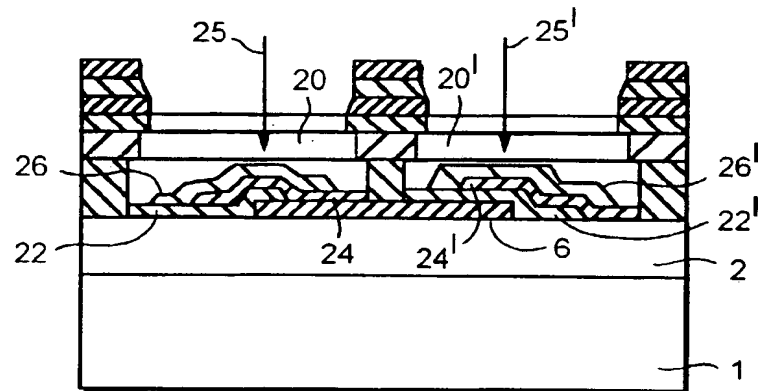


FIG. 20(f)

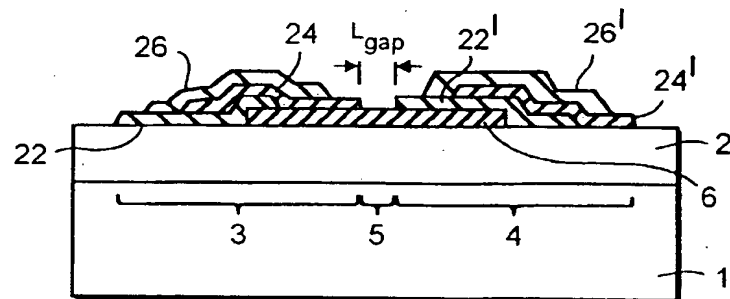


FIG. 20(g)

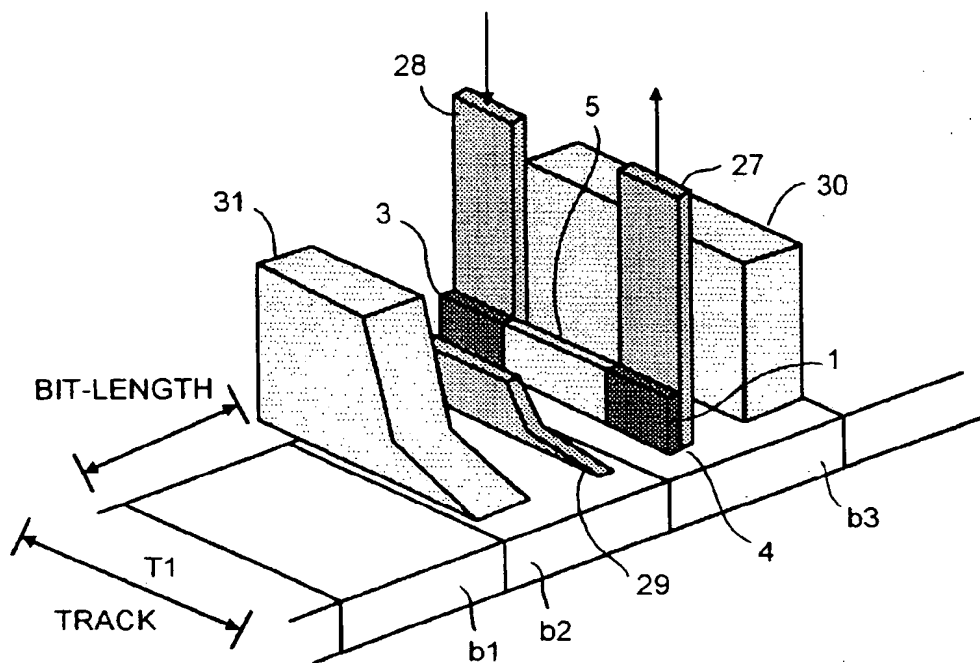


FIG. 21

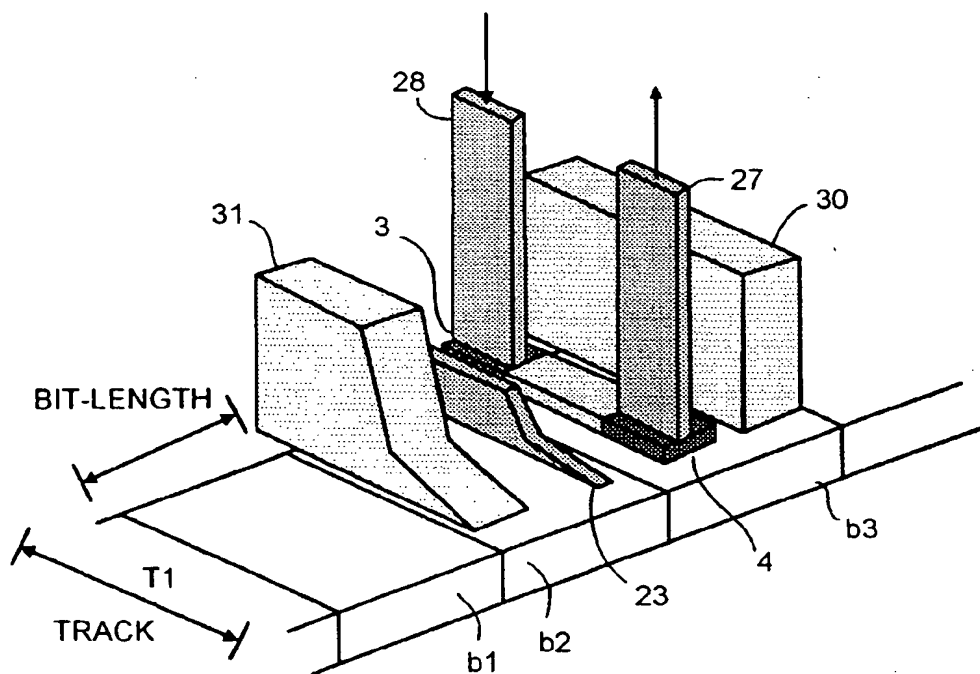


FIG. 22



European Patent
Office

EUROPEAN SEARCH REPORT

Application Number
EP 99 30 3615

DOCUMENTS CONSIDERED TO BE RELEVANT			
Category	Citation of document with indication, where appropriate, of relevant passages	Relevant to claim	CLASSIFICATION OF THE APPLICATION (Int.Cl.7)
X	US 5 747 859 A (KINNO TERUYUKI ET AL) 5 May 1998 (1998-05-05) * column 6, line 37 - line 39 * * column 14, line 59 - line 64 *	8	G01R33/09 H01F10/08 G11B5/33
Y	----	18,22,23	
Y	WO 98 25263 A (PHILIPS ELECTRONICS NV ;PHILIPS NORDEN AB (SE)) 11 June 1998 (1998-06-11) * page 8, line 23 - page 9, line 14 *	18,22,23	
A	TSEBRO V I ET AL: "TEMPERATURE DEPENDENCE OF ELECTRIC RESISTANCE AND MAGNETORESISTANCE OF PRESSED NANOCOMPOSITES OF MULTILAYER NANOTUBES WITH THE STRUCTURE OF NESTED CONES" JOURNAL OF EXPERIMENTAL AND THEORETICAL PHYSICS, vol. 86, no. 6, 1 June 1998 (1998-06-01), pages 1216-1219, XP000776015 ISSN: 1063-7761 * page 1218, left-hand column *	1	
A	US 5 726 837 A (FUKUOKA HIROTSUGU ET AL) 10 March 1998 (1998-03-10) * column 1, line 43 - line 60 * * column 3, line 12 - line 24 *	1,16,17	G01R H01F
The present search report has been drawn up for all claims			
Place of search THE HAGUE		Date of completion of the search 11 October 1999	Examiner Swartjes, H
<p>CATEGORY OF CITED DOCUMENTS</p> <p>X : particularly relevant if taken alone Y : particularly relevant if combined with another document of the same category A : technological background O : non-written disclosure P : intermediate document</p> <p>T : theory or principle underlying the invention E : earlier patent document, but published on, or after the filing date D : document cited in the application L : document cited for other reasons & : member of the same patent family, corresponding document</p>			

EPO FORM 1503 03/82 (P4/C01)

